TOSHIBA Bipolar Linear Integrated Circuit Silicon Monolithic

# TA7291AP, TA7291AS(J)/ ASG(J), TA7291AF/AFG

Full-Bridge Driver for DC Motors (driver for controlling the forward and reverse rotations)

The TA7291AP/AS (J)/ASG(J)/AF/AFG is a full-bridge driver to control the forward and reverse rotations. Each driver can select one of four modes: CW, CCW, stop, brake.

The TA7291AP is designed to provide output currents of 1.0 A (typ.) and 2.0 A (peak). The TA7291AS (J)/ASG(J)/AF/AFG is designed to provide output currents of 0.4 A (typ.) and 1.2 A (peak).

There are two different power supply pins for each driver: one on the output side and the other on the control side of the driver. Also, there is a  $V_{\rm ref}$  pin on the output side. This pin is available for adjusting the voltage supplied to the motor.

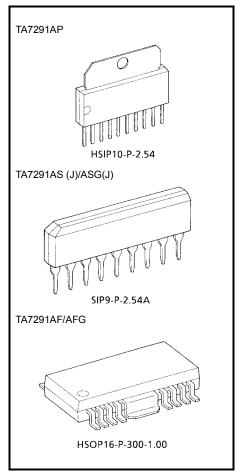
The input circuit of the driver is compatible with CMOS logic because it draws a small amount of input current.

#### **Features**

- Wide range of operating voltage:  $V_{CC (opr.)} = 4.5 \text{ V}$  to 27 V
  - $V_{S (opr.)} = 4.5 \text{ V to } 27 \text{ V}$
  - :  $V_{ref (opr.)} = 4.5 V to 27 V$

 $V_{ref} \; must \; be \leq V_S.$ 

- Output current: AP type 1.0 A (typ.) 2.0 A (peak)
  - : AS (J)/AF type 0.4 A (typ.) 1.2 A (peak)
- Thermal shutdown and overcurrent protection
- · Flyback diodes
- Hysteresis for all inputs
- · Standby mode available



Weight HSIP10-P-2.54: 2.47 g (typ.) SIP9-P-2.54A: 0.92 g (typ.) HSOP16-P-300-1.00: 0.50 g (typ.)

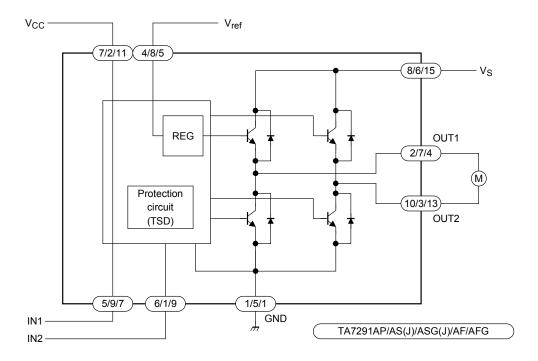
#### TA7291ASG(J)/AFG:

The following conditions apply to solderability: \*Solderability

- 1. Use of Sn-63Pb solder bath
  - \*solder bath temperature=230 degrees
  - \*dipping time=5seconds
  - \*number of times=once
  - \*use of R-type flux
- 2. Use of Sn-3.0Ag-0.5Cu solder bath
  - \*solder bath temperature=245 degrees
  - \*dipping time=5seconds
  - \*the number of times=once



# **Block Diagram**



# **Pin Function**

Symbol	Pin No.			Function Description	
	AP A		AF	i unction Description	
V <sub>CC</sub>	7	2	11	Supply voltage pin for logic	
V <sub>S</sub>	8	6	15	Supply voltage pin for motor driver	
V <sub>ref</sub>	4	8	5	Supply voltage pin for control	
GND	1	5	1	Ground pin	
IN1	5	9	7	Input pin	
IN2	6	1	9	Input pin	
OUT1	2	7	4	Output pin	
OUT2	10	3	13	Output pin	

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AP type: Pin 3 and 9 are NC. AS (J) type: Pin 4 is NC.

AF type: Pin 2, 3, 6, 8, 10, 12, 14, and 16 are NC.

For F type, we recommend the fin be connected to ground.

## **Function**

Input		Out	tput	Mode	
IN1	IN2	OUT1	OUT2	Wode	
0	0	∞	∞	Stop	
1	0	Н	L	CW/CCW	
0	1	L	Н	CCW/CW	
1	1	L	L	Brake	

∞: High impedance

Note: Inputs are all active high.

# Maximum Ratings (Ta = 25°C)

Characteristics			Symbol	Rating	Unit	
Supply voltage			V <sub>CC</sub>	30	V	
			V <sub>CC</sub> (opr.)	27		
Motor drive voltage			Vs	30	V	
			V <sub>S (opr.)</sub>	27	V	
Deference veltage			V <sub>ref</sub>	30	V	
Reference voltage		V <sub>ref (opr.)</sub>	27			
Output current	Peak	AP type	la ( )	2.0	А	
	Feak	AS (J)/AF type	IO (peak)	1.2		
	Tyrp	AP type	la «	1.0	A	
	Тур.	A S(J)/AF type	I <sub>O (typ.)</sub>	0.4		
Power dissipation AS (J) type  AF type			12.5 (Note 1)			
		AS (J) type	$P_{D}$	0.95 (Note 2)	W	
		) 	1.4 (Note 3)			
Operating temperature			T <sub>opr</sub>	−30 to 75	°C	
Storage temperature			T <sub>stg</sub>	−55 to 150	°C	

Note 1:  $Tc = 25^{\circ}C$ 

Note 2: No heat sink

Note 3: When mounted on a PCB (PCB area:  $60 \text{ mm} \times 30 \text{ mm} \times 1.6 \text{ mm}$ , Cu area: 50% or more)

Wide range of operating voltage:  $V_{CC\ (opr.)} = 4.5\ V$  to 27 V

 $V_{S (opr.)} = 4.5 V to 27 V$ 

 $V_{ref (opr.)} = 4.5 V to 27 V$ 

 $V_{ref} \leq V_S$ 



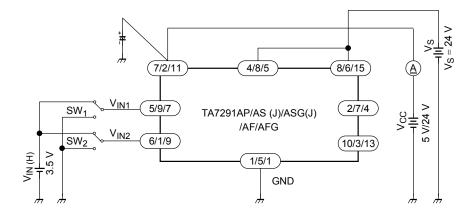
# Electrical Characteristics (Ta = 25°C, $V_{CC}$ = 5 V, $V_{S}$ = 24 V)

Characteristics		Symbol	Test Circuit	Test Condition	Min	Тур.	Max	Unit		
Supply current		I <sub>CC1-1</sub>	1	Output OFF, CW/CCW mode	_	6.0	11.0			
		I <sub>CC1-2</sub>		Output OFF, CW/CCW mode, V <sub>CC</sub> = 24 V	_	8.0	13.0	mA		
		I <sub>CC2-1</sub>		Output OFF, Stop mode	_	0	50	μΑ		
		I <sub>CC2-2</sub>		Output OFF, Stop mode, V <sub>CC</sub> = 24 V	_	0	50			
		I <sub>CC3-1</sub>		Output OFF, Brake mode	_	4.5	8.0			
		I <sub>CC3-2</sub>		Output OFF, Brake mode, V <sub>CC</sub> = 24 V	_	6.5	10.0	mA		
Input	1 (High)		V <sub>IN1</sub>	2	T. 25°C	3.5	_	5.5	V	
operating voltage	2 (Low)		$V_{\text{IN2}}$		$T_j = 25^{\circ}C$	GND	_	0.8		
Input current		I <sub>IN</sub>		V <sub>IN</sub> = 3.5 V, Sink mode	_	3	10	μА		
Saturation voltage	AP/AS (J)/	Upper side	V <sub>SAT U-1</sub>		$V_{ref} = V_S$ , $V_{OUT}$ - $V_S$ measure $I_O = 0.2$ A, CW/CCW mode	_	0.9	1.2	V	
	AF type	Lower side	V <sub>SAT L-1</sub>	3	V <sub>ref</sub> = V <sub>S</sub> , V <sub>OUT</sub> -GND measure I <sub>O</sub> = 0.2 A, CW/CCW mode	_	0.8	1.2		
	AS (J)/AF	Upper side	V <sub>SAT U-2</sub>		$V_{ref} = V_S$ , $V_{OUT}$ - $V_S$ measure $I_O = 0.4$ A, CW/CCW mode	_	1.0	1.35		
	type	Lower	V <sub>SAT L-2</sub>		$V_{ref} = V_S$ , $V_{OUT}$ -GND measure $I_O = 0.4$ A, CW/CCW mode	_	0.9	1.35		
	AD 4	Upper side	V <sub>SAT U-3</sub>		$V_{ref} = V_S$ , $V_{OUT}$ - $V_S$ measure $I_O = 1.0$ A, $CW/CCW$ mode	_	1.3	1.8		
	AP type	Lower side	V <sub>SAT L-3</sub>		V <sub>ref</sub> = V <sub>S</sub> , V <sub>OUT</sub> -GND measure I <sub>O</sub> = 1.0 A, CW / CCW mode	_	1.2	1.85		
	AC / I)/AE &		V <sub>SAT U-1</sub>		V <sub>ref</sub> : 10 V, V <sub>OUT</sub> -GND measure I <sub>O</sub> = 0.2 A, CW / CCW mode	_	11.2	_		
Output voltage (upper side)	AS (J)/AF type		V <sub>SAT U-2</sub>	3	V <sub>ref</sub> : 10 V, V <sub>OUT</sub> -GND measure I <sub>O</sub> = 0.4 A, CW/CCW mode	10.4	10.9	12.2	- V	
	AD to make		V <sub>SAT U-3</sub>		V <sub>ref</sub> : 10 V, V <sub>OUT</sub> -GND measure I <sub>O</sub> = 0.5 A, CW/CCW mode	_	11.0	_		
	AF type	AP type			$V_{ref}$ : 10 V, $V_{OUT}$ -GND measure $I_{O}$ = 1.0 A, CW/CCW mode	10.2	10.7	12.0		
Leakage current  Lower side		<sup>I</sup> L U	_	V <sub>L</sub> = 30 V	_		50			
			I <sub>L L</sub>	4	V <sub>L</sub> = 30 V	_	_	50	— μA	
Diode forward – voltage	AS (J)/AF type	Upper side	V <sub>F U-1</sub>		_	_	1.5	_		
	AP type	Lower side	V <sub>F U-2</sub>	5	_	_	2.5	_	V	
	AS (J)/AF type	Upper side	V <sub>F L-1</sub>	] 3	_	_	0.9	_		
		Lower side	V <sub>F L-2</sub>		_	_	1.2	_		
Reference current		I <sub>ref</sub>	2	V <sub>ref</sub> = 10 V, Source mode	_	_	40	μА		

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# **Test Circuit 1**

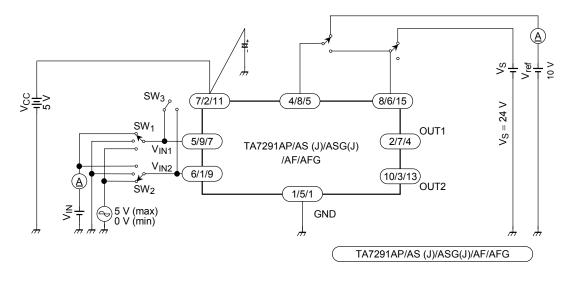
ICC1-1, ICC1-2, ICC2-1, ICC2-2, ICC3-1, ICC3-2



Note: The heat fin of the TA7291AF/AFG is connected to ground.

# **Test Circuit 2**

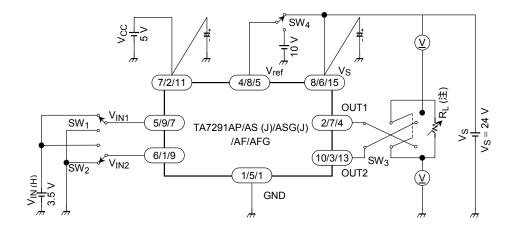
# $V_{IN1}$ , $V_{IN2}$ , $I_{IN}$ , $I_{ref}$



Note: The heat fin of the TA7291AF/AFG is connected to ground.

## **Test Circuit 3.**

## VSAT U-1, 2, 3 VSAT L-1, 2, 3 VSAT U-1', 2', 3', 4'

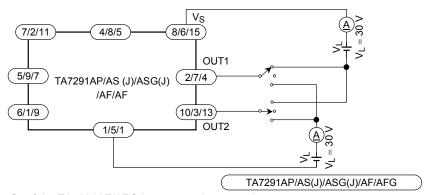


Note 1:  $I_{OUT}$  calibration is required to adjust the specified values of test conditions by R<sub>L</sub>.  $(I_{OUT}=0.2 \text{ A}/0.4 \text{ A}/0.5 \text{ A}/1.0 \text{ A})$ 

Note 2: The heat fin of the TA7291AF/AFG is connected to ground.

#### Test Circuit 4.

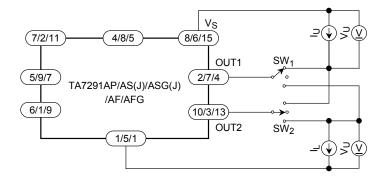
## I<sub>LU</sub>, L



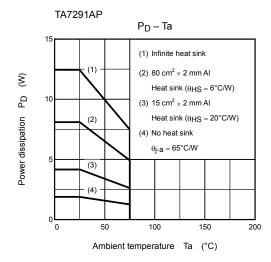
Note: The heat fin of the TA7291AF/AFG is connected to ground.

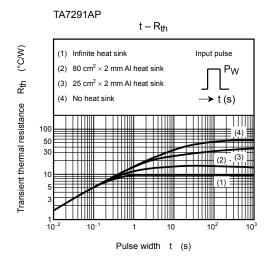
#### Test Circuit 5.

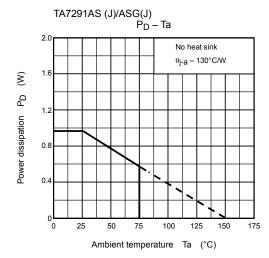
## $V_{F U-1, 2} V_{F L-1, 2}$

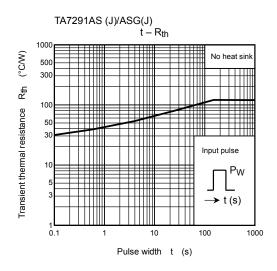


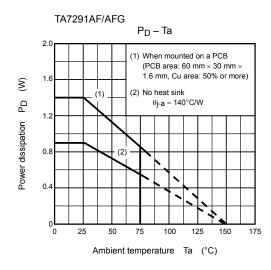
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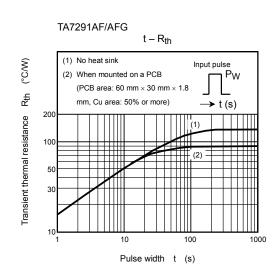


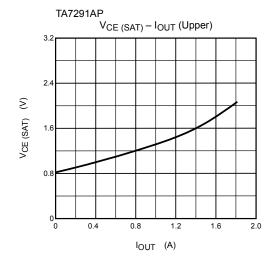


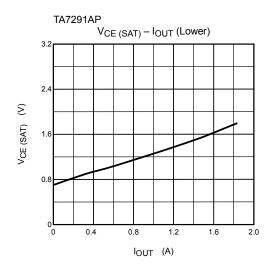


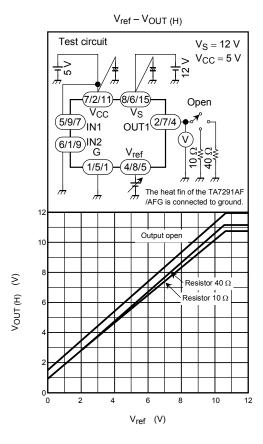


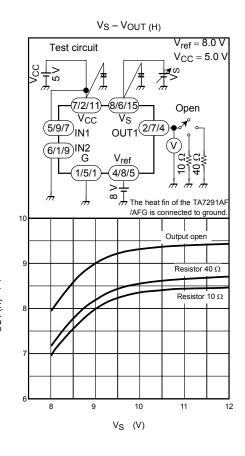












#### **Notes**

#### Power On/Off

At power on, VCC must be applied simultaneously or before Vs. At power off, VCC must be removed simultaneously or after Vs.

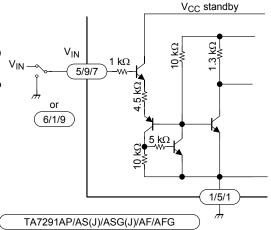
#### Input Circuit

A logic high on the VIN pin activates the input circuit as shown in the figure.

When a voltage greater than or equal to  $V_{\rm IN}$  (high) is applied to the pin, the circuit is active. When a voltage less than or equal to  $V_{\rm IN}$  (low) is applied to the pin or the pin is grounded, the circuit is inactive.

When the pin is high, the input current I<sub>IN</sub> flows into the input circuit. Take particular care, therefore, with the output impedance of the first stage.

The input hysteresis is 0.7 V (typ.). At power on (VCC), set both input pins IN1 and IN2 to low.



## Output Circuit

#### Output high voltage

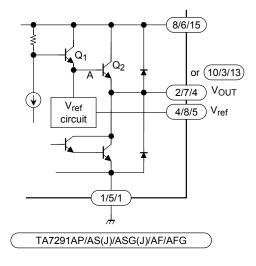
Operation based on the V<sub>ref</sub> voltage
 The V<sub>ref</sub> voltage is increased by twice the value of V<sub>BE</sub> (small signal) in the V<sub>ref</sub> circuit. The voltage is then applied to the base A of Q2 (power transistor 2). As a result, a voltage reduced by the value of V<sub>BE</sub> (Q2) appears on the V<sub>OUT</sub> pin.

 $V_{OUT} = V_{ref} + 2V_{BE} - V_{BE} (Q_2) \simeq V_{ref} + 0.7 V$ 

Vref pin

The  $V_{ref}$  pin must not be left open when unused. In this case, connect it via a protection resistor (3  $k\Omega$  or more) to the  $V_{\rm S}$  pin. Otherwise, it might cause oscillation.

 $V_{ref}$  must be  $\leq V_{S}$ .



#### **Protection Features**

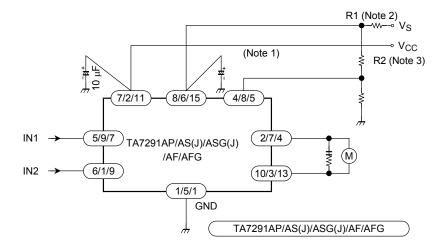
## **Overcurrent Protection Circuit**

The overcurrent protection circuit detects a current flowing through the upper power transistor. If the current exceeds a predetermined value (about 2.5 A), the circuit turns all the power transistors off. However, it does not always prevent overcurrent. If an output pin is shorted or grounded, the IC might be destroyed before operation of the overcurrent protection circuit. Be sure, therefore, to connect a resistor or fuse to the power supply (Vg) line. (See "Application Circuit.")

#### Thermal Shutdown Circuit

If the chip temperature exceeds a predetermined limit (about 170°C), the thermal shutdown circuit turns all the power transistors off.

# **Application Circuit**

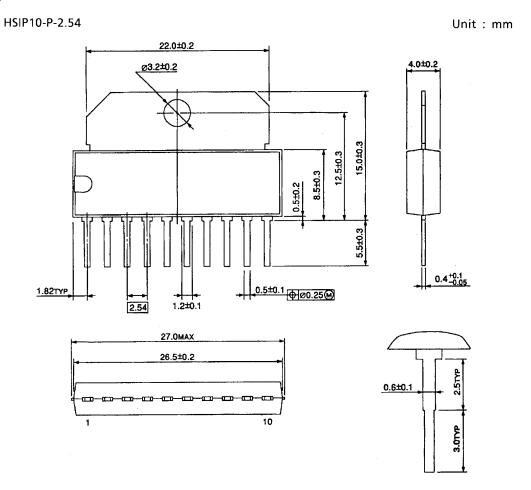


- Note 1: Select the optimum value for the capacitor by trial and error.
- Note 2: Insert the current limiting resistor R1 to protect the IC from overcurrent.
- Note 3: When  $V_S = V_{ref}$ , insert the resistor R2 (3 k $\Omega$  or more) to protect the  $V_{ref}$  pin from being damaged by a surge.
- Note 4: The IC may be destroyed due to short circuit between output pins, an output pin and V<sub>CC</sub>, or an output pin and ground. Design the output line, V<sub>CC</sub> (V<sub>M</sub>, V<sub>S</sub>, V<sub>EE</sub>) lines and the ground line with great care.

#### **Note**

- Shoot-through current occurs when the mode is switched. The driver must enter the stop mode for approximately 100 µs before switching between CW and CCW modes, or CW/CCW and brake modes.
- Normal IC functionality is not guaranteed at power on/off. Before using the IC, check that any IC malfunctions that are possible at power on/off will not cause a problem in the IC application.

# **Package Dimensions**

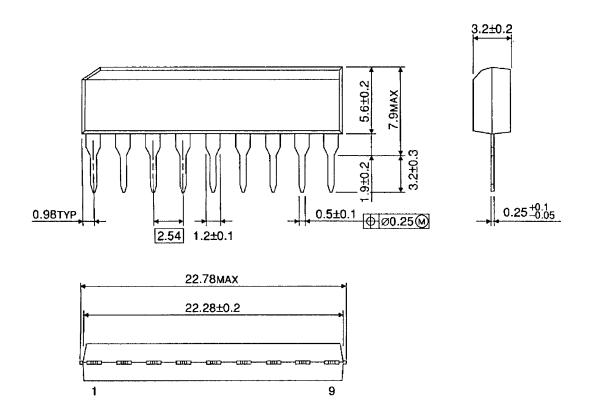


Weight: 2.47 g (typ.)

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# **Package Dimensions**

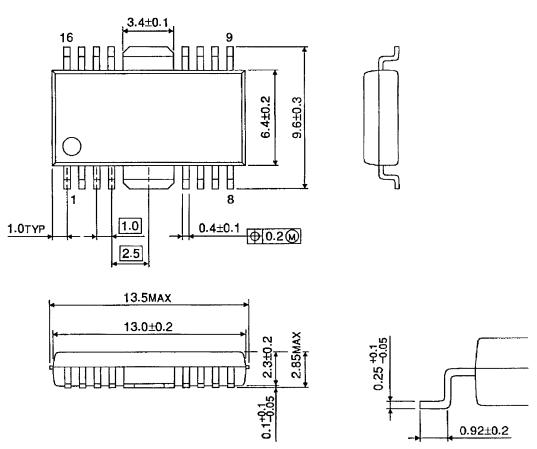
SIP9-P-2.54A Unit: mm



Weight: 0.92 g (typ.)

# **Package Dimensions**

HSOP16-P-300-1.00 Unit: mm



Weight: 0.50 g (typ.)

#### The notes of contents

#### 1.Block Diagram

Some of the functional blocks, circuits, or constants in the block diagram may be omitted or simplified for explanatory purposes.

#### 2. Equivalent Circuit

The equivalent circuit diagrams may be simplified or some parts of them may be omitted for explanatory purposes.

## 3. Timing charts

Timing charts may be simplified for explanatory purposes.

#### 4. Maximum Ratings

The absolute maximum ratings of a semiconductor device are a set of specified parameter values which must not be exceeded during operation, even for an instant.

If any of these ratings are exceeded during operation, the device electrical characteristics may be irreparably altered and the reliability and lifetime of the device can no longer be guaranteed.

Moreover, these operations with exceeded ratings may cause breakdown, damage and/or degradation to other equipment. Applications using the device should be designed so that each maximum rating will never be exceeded in any operating conditions.

Before using, creating and/or producing designs, refer to and comply with the precautions and conditions set forth in this document.

#### 5. Application Circuit

The application circuits shown in this document are provided for reference purposes only. Thorough evaluation is required, especially at the mass production design stage.

Toshiba does not grant any license to any industrial property rights by providing these examples of application circuits.

#### 6.Test Circuit

Components in the test circuits are only used to obtain and confirm the device characteristics. These components and circuits are not guaranteed to prevent malfunction or failure from occurring in the application equipment.

#### About the handling of IC

Install the product correctly to avoid breakdown, damage and/or degradation to the product or equipment.

#### About overcurrent protection and heat protection circuit

These protection functions are intended to guard against certain output short circuits or other abnormal conditions with only temporary effect, and are not guaranteed to prevent the IC from being damaged.

- These protection features may not be effective if the product is operated outside the guaranteed operating ranges, and some output short circuits may result in the IC being damaged.

The overcurrent protection feature is only intended to protect the IC from a temporary short circuit.

Short circuits of longer duration may damage the IC through undue stress. The systems must be configured so that any overcurrent condition will be eliminated as soon as possible.

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